

FDW2520C

Complementary PowerTrench® MOSFET

General Description

This complementary MOSFET device is produced using Fairchild's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

Applications

- DC/DC conversion
- · Power management
- · Load switch

Features

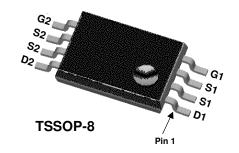
Q1: N-Channel

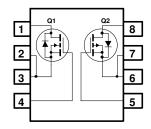
6 A, 20 V. $R_{DS(ON)} = 18 \ m\Omega \ @ \ V_{GS} = 4.5 \ V$ $R_{DS(ON)} = 28 \ m\Omega \ @ \ V_{GS} = 2.5 \ V$

Q2: P-Channel

-4.4A, 20 V. $R_{DS(ON)} = 35 \ m\Omega \ @\ V_{GS} = -4.5 \ V$ $R_{DS(ON)} = 57 \ m\Omega \ @\ V_{GS} = -2.5 \ V$

- High performance trench technology for extremely low R_{DS(ON)}
- Low profile TSSOP-8 package





Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units
V _{DSS}	Drain-Source Voltage		20	-20	V
V _{GSS}	Gate-Source Voltage		±12	±12	V
I _D	Drain Current - Continuous (N	ote 1a)	6	-4.4	Α
	- Pulsed		30	-30	
P _D	Power Dissipation (i	Note 1a)	1.	.0	W
	1)	Note 1b)	0.	.6	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		–55 to	+150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	125	°C/W
		(Note 1b)	208	

Package Marking and Ordering Information

Device Marking	Device	Reel Size Tape width		Quantity	
2520C	FDW2520C	13"	12mm	2500 units	

Symbol	Parameter	Test Conditions	Type	Min	Тур	Max	Units
Off Char	acteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ $V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	Q1 Q2	20 –20			V
ΔBV _{DSS} ΔΤ _J	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, Referenced to 25°C I_D = -250 μA, Referenced to 25°C	Q1 Q2		14 –17		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 16 V, V _{GS} = 0 V V _{DS} = -16 V, V _{GS} = 0 V	Q1 Q2			1 -1	μА
I _{GSS}	Gate-Body Leakage	$V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$ $V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$	Q1 Q2			<u>+</u> 100 +100	nA
On Char	acteristics (Note 2)				•	. —	•
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$ $V_{DS} = V_{GS}, I_D = -250 \mu A$	Q1 Q2	0.4 -0.4	1.0 -1.0	1.5 -1.5	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C I _D = –250 μA, Referenced to 25°C	Q1 Q2		-3.3 3.1		mV/°C
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 4.5 V, I _D = 6 A V _{GS} = 2.5 V, I _D = 5 A V _{GS} = 4.5 V, I _D = 6 A, T _J = 125°C	Q1		14 19 19	18 28 29	mΩ
		$V_{GS} = -4.5 \text{ V}, I_D = -4.4 \text{ A}$ $V_{GS} = -2.5 \text{ V}, I_D = -3.3 \text{ A}$	Q2		28 43 39	35 57 56	mΩ
I _{D(on)}	On-State Drain Current	$V_{GS} = -4.5 \text{ V}, I_D = -4.4 \text{ A}, T_J = 125^{\circ}\text{C}$ $V_{GS} = 4.5 \text{ V}, V_{DS} = 5 \text{ V}$ $V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$	Q1 Q2	30 –30			Α
g _{FS}	Forward Transconductance	$V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$ $V_{DS} = 5 \text{ V}, I_D = 6 \text{ A}$ $V_{DS} = -5 \text{ V}, I_D = -4.4 \text{ A}$	Q1 Q2		30 17		S
Dynamic	Characteristics						
C _{iss}	Input Capacitance	Q1: V _{DS} = 10 V, V _{GS} = 0 V,	Q1 Q2		1325 1330		pF
Coss	Output Capacitance	f = 1.0 MHz Q2:	Q1 Q2		358 552		pF
C _{rss}	Reverse Transfer Capacitance	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz	Q1 Q2		168 153		pF
Switchine	g Characteristics						
t _{d(on)}	Turn-On Delay Time	Q1: V _{DD} = 10 V, I _D = 1 A,	Q1 Q2		6 12	20 25	ns
t _r	Turn-On Rise Time	V_{GS} = 4.5V, R_{GEN} = 6 Ω Q2:	Q1 Q2		11 19	40 40	ns
$t_{d(off)}$	Turn-Off Delay Time	$V_{DD} = -10 \text{ V}, I_{D} = -1 \text{ A},$ $V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$	Q1 Q2		32 60	60 100	ns
t _f	Turn-Off Fall Time		Q1 Q2		19 37	34 70	ns
Q_g	Total Gate Charge	Q1: V _{DS} = 10 V, I _D = 6 A,	Q1 Q2		14 14	20 20	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 4.5 V Q2:	Q1 Q2		2.6 3.0		nC
Q _{gd}	Gate-Drain Charge	$V_{DS} = -5 \text{ V}, I_{D} = -4.4 \text{ A},$ $V_{GS} = -4.5 \text{ V}$	Q1 Q2		3.7 3.9		nC

Electrical Characteristics (continued)

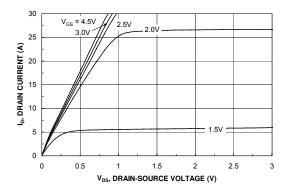
T_A = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Drain-Source Diode Characteristics and Maximum Ratings							
I _s	Maximum Continuous Drain-Source Diode Forward Current		Q1			0.83	Α
			Q2			-0.83	
V _{SD}	Drain-Source Diode Forward	$V_{GS} = 0 \text{ V}, I_S = 0.83 \text{ A}$ (Note 2) $V_{GS} = 0 \text{ V}, I_S = -0.83 \text{ A}$ (Note 2)	Q1		0.5	1.2	V
	Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -0.83 \text{ A}$ (Note 2)	Q2		-0.7	-1.2	

Notes:

- R_{8JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{8JC} is guaranteed by design while R_{8CA} is determined by the user's board design.
 - a) $\rm\,R_{\rm \theta JA}$ is 125°C/W (steady state) when mounted on a 1 inch² copper pad on FR-4.
 - b) $R_{\theta JA}$ is 208°C/W (steady state) when mounted on a minimum copper pad on FR-4.
- 2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

Typical Characteristics: Q1



Region 1.8

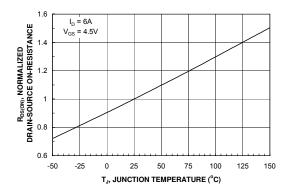
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Figure 1. On-Region Characteristics.

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.



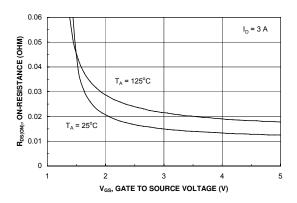
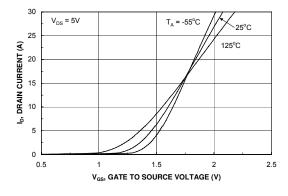


Figure 3. On-Resistance Variation with Temperature.

Figure 4. On-Resistance Variation with Gate-to-Source Voltage.



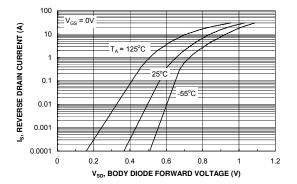
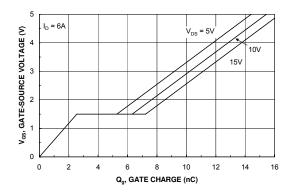


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

f = 1MHz V_{GS} = 0 V

Typical Characteristics: Q1



C_{OSS} 1250 C_{OSS}

2000

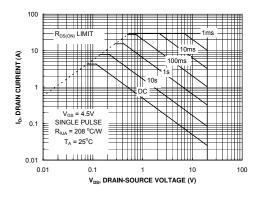
1750

1500

C_{ISS}

Figure 7. Gate Charge Characteristics.

Figure 8. Capacitance Characteristics.



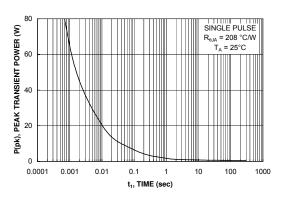


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

Typical Characteristics: Q2

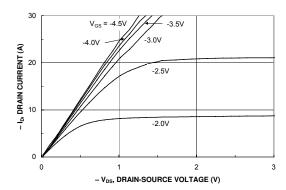


Figure 11. On-Region Characteristics.

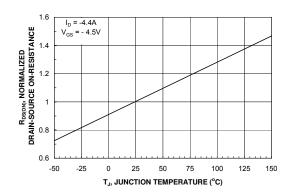


Figure 13. On-Resistance Variation with Temperature.

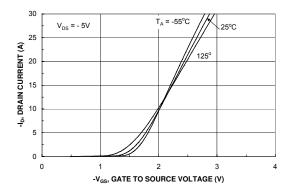


Figure 15. Transfer Characteristics.

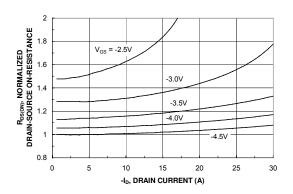


Figure 12. On-Resistance Variation with Drain Current and Gate Voltage.

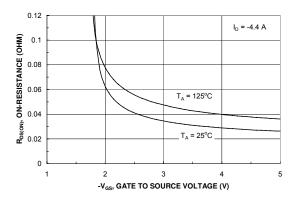


Figure 14. On-Resistance Variation with Gate-to-Source Voltage.

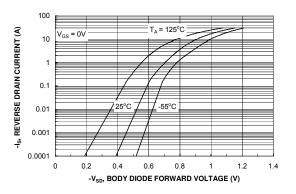
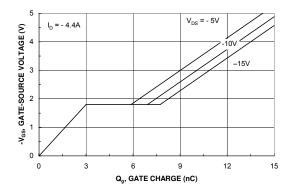


Figure 16. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics: Q2



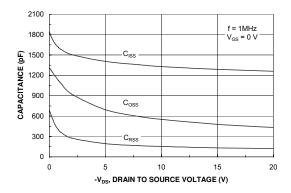
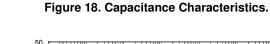
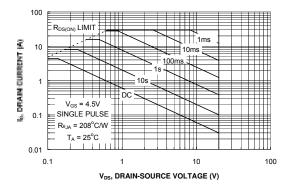


Figure 17. Gate Charge Characteristics.





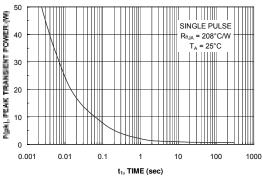


Figure 19. Maximum Safe Operating Area.

Figure 20. Single Pulse Maximum Power Dissipation.

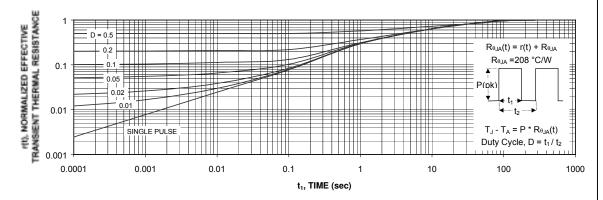


Figure 21. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.





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